# Neural Relation Graph: A Unified Framework for Identifying Label Noise and Outlier Data

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# **Goal of research**

- Dataset cleaning: Identifying problematic data
  - Identifying problems regarding labels or input data
  - Developing domain-agnostic and scalable methods for label error and outlier detection

- Data analysis: Characterizing data points
  - Answering "Why does the model make such predictions?" from a data perspective
  - Building a more reliable evaluation system

### **Conventional approach**



- Conventional approach for identifying problematic data is to measure an **unary score** for each data:
  - prediction margin<sup>1</sup>
  - self-influence<sup>2</sup>
  - sensitivity<sup>3</sup>

<sup>1</sup>Northcutt et al., Confident learning: Estimating uncertainty in dataset labels, 2021 <sup>2</sup>Koh et al., Understanding black-box predictions via influence functions, 2017

 $^{3}\mbox{Liang et al., Enhancing the reliability of out-of-distribution image detection in neural networks, 2018$ 

### **Proposed approach**



• We propose a unified approach for detecting label noise and outlier data by utilizing relational structure of data.

# Assumption

- Noisy training dataset  $\mathcal{T} = \{(x_i, y_i) \mid i = 1, \dots, n\}.$ 
  - May have problems in  $x_i$  (outlier) or  $y_i$  (label error).
- Trained neural networks on  $\mathcal{T}$ .
  - Extract feature representation  $f_i$ .
  - Measure the semantic similarity  $k : \mathcal{X} \times \mathcal{X} \rightarrow [0, M]$  between data (higher means more similarity).

#### **Data relation**

• Given data  $(x_i, y_i)$  and  $(x_j, y_j)$ , we define relation between data:  $r((x_i, y_i), (x_j, y_j)) = 1(y_i = y_j) \cdot k(x_i, x_j).$ 

Here,  $1(y_i = y_j) \in \{-1, 1\}.$ 

• Similar to the influence function, data relation quantifies the complementarity of a data pair.



- Goal: Measure the label noisiness score  $s \in \mathbb{R}^n$  for dataset  $\mathcal{T} = \{1, \dots, n\}.$ 
  - A higher score indicates a higher likelihood of label error.

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- We consider a fully-connected undirected graph  $\mathcal{G} = (\mathcal{V}, \mathcal{E}, \mathcal{W})$ .
  - Node set  $\mathcal{V} = \mathcal{T}$ .
  - Weights  ${\mathcal W}$  on edges  ${\mathcal E}$  are the negative relation values:

$$w(i, j) = -r(i, j) = -r((x_i, y_i), (x_j, y_j)).$$

• Simple approach: Aggregate edge weights as  $s[i] = \sum_{j=1}^{n} w(i, j)$ .  $\Rightarrow$  Edge values can affect both the clean and unclean data.

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  ⇒ Edge values can affect both the clean and unclean data.
- We jointly estimate the **noisy subset**  $\mathcal{N} \subset \mathcal{T}$  that are likely to have incorrect labels:

$$\mathcal{N}^* = \underset{\mathcal{N} \subset \mathcal{T}}{\operatorname{argmax}} \operatorname{cut}(\mathcal{N}, \mathcal{T} \setminus \mathcal{N}) \Big( \coloneqq \sum_{i \in \mathcal{N}} \sum_{j \in \mathcal{T} \setminus \mathcal{N}} w(i, j) \Big) - \lambda |\mathcal{N}|.$$

 $\Rightarrow$  Max-cut problem, which is NP-hard.

• Motivated by Kerninghan-Lin algorithm, we alternatively update s and  $\mathcal{N}:$ 

$$\begin{split} s[i] &= \sum_{j \in \mathcal{T} \setminus \mathcal{N}} w(i,j) - \sum_{j \in \mathcal{N}} w(i,j) \\ \mathcal{N} &= \{i \mid s[i] > \lambda, i \in [1, \dots, n]\}. \end{split}$$



# **OOD**/outlier detection

Outlier score calculation



• We measure the **outlier score** (higher scores indicate greater outlierness) of a data point x as

outlier(x) = 
$$\frac{1}{\sum_{i \in S} k(x, x_i)}$$

• Here, S is a random subset of T.

- Reflect global characteristics of data distribution.
- Only 1% is enough in the case of ImageNet.

# **Kernel function**

• We propose the following class of bounded kernel:

$$k(x_i, x_j) = |s(\mathbf{f}_i, \mathbf{f}_j) \cdot c(\mathbf{p}_i, \mathbf{p}_j)|^t,$$

where hyperparameter  $t > 0 \mbox{ controls the kernel distribution's sharpness.} \label{eq:total_star}$ 

- Feature similarity:  $s(\mathbf{f}_i, \mathbf{f}_j) = \max(0, \cos(\mathbf{f}_i, \mathbf{f}_j))$
- Prediction compatibility:  $c(\mathbf{p}_i, \mathbf{p}_j) = P(\widehat{y}_i = \widehat{y}_j) = \mathbf{p}_i^\mathsf{T} \mathbf{p}_j$
- Our framework demonstrates strong performance across various kernel types, including RBF kernels.

### **Experiment results: Label error detection**

• An MAE-Large model on ImageNet with synthetic label noise.



# **Experiment results: Label error detection**

 Detected data samples with label errors from ImageNet and SST2 (text sentiment classification).













Negative	Positive (-0.850)	Positive (-0.846)
"entertaining and informative documentary"	"entertaining movie"	"fascinating and timely content

### **Experiment results: OOD detection**

An MAE-Large model on ImageNet validation set with various OOD datasets.



# Experiment results: Outliers in validation set

• Detected outlier validation samples from ImageNet (top) and SST2 (bottom).



# Summary

- We propose a unified approach for identifying label errors and outlier data points.
- We develop domain-agnostic and scalable detection algorithms.
- https://github.com/snu-mllab/Neural-Relation-Graph

